## Applicant(s)/Patent Under Application/Control No. Reexamination 10/633,556 SANO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1751 Mark Kopec **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-5,807,508 09-1998 Kawahara et al. 252/512 В US-С US-US-D Ε US-F US-G US-Н US-US-US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0

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